

<b>Notice of References Cited</b>	Application/Control No. 10/026,970	Applicant(s)/Patent Under Reexamination HAMANO ET AL.	
	Examiner John B Strege	Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,789,238	12-1988	Ichikawa et al.	356/237.2
	B	US-6,603,540	08-2003	Kaupp, Ansgar	356/237.1
	C	US-5,760,907	06-1998	Basler et al.	356/390
	D	US-5,073,951	12-1991	Hayashi, Yoichi	382/141
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.